

Search Notes

Application/Control No.

10/801,371

Examiner

HUYEN D. LE

Applicant(s)/Patent under
Reexamination

FENG, JEN NAN

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner
381	113, 174, 175, 176, 178, 190,	4/12/2007	HL
381	191		HL
381	355		HL
381	369		HL
381	398		HL
381	409-410		HL
29	25.41		HL
29	25.42		HL
29	594		HL
307	400		HL
367	140		HL
367	170		HL
367	181		HL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as above		4/12/2007	HL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR